

PHE13005X

Silicon diffused power transistor

Rev. 01 — 15 May 2008

Product data sheet

1. Product profile

1.1 General description

High voltage, high speed, planar passivated NPN power switching transistor in a full pack plastic package.

1.2 Features

- Low thermal resistance
- Isolated package
- Fast switching

1.3 Applications

- Electronic lighting ballasts
- Inverters
- DC-to-DC converters
- Motor control systems

1.4 Quick reference data

- $V_{CESM} \leq 700$ V; $V_{BE} = 0$ V
- $P_{tot} \leq 26$ W; $T_h \leq 25$ °C
- $I_C \leq 4$ A; DC
- $h_{FE} = 17$ (typical); $I_C = 2$ A; $V_{CE} = 5$ V

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	base	<p>SOT186A (TO-220F)</p>	<p>sym056</p>
2	collector		
3	emitter		
mb	isolated		

3. Ordering information

Table 2. Ordering information

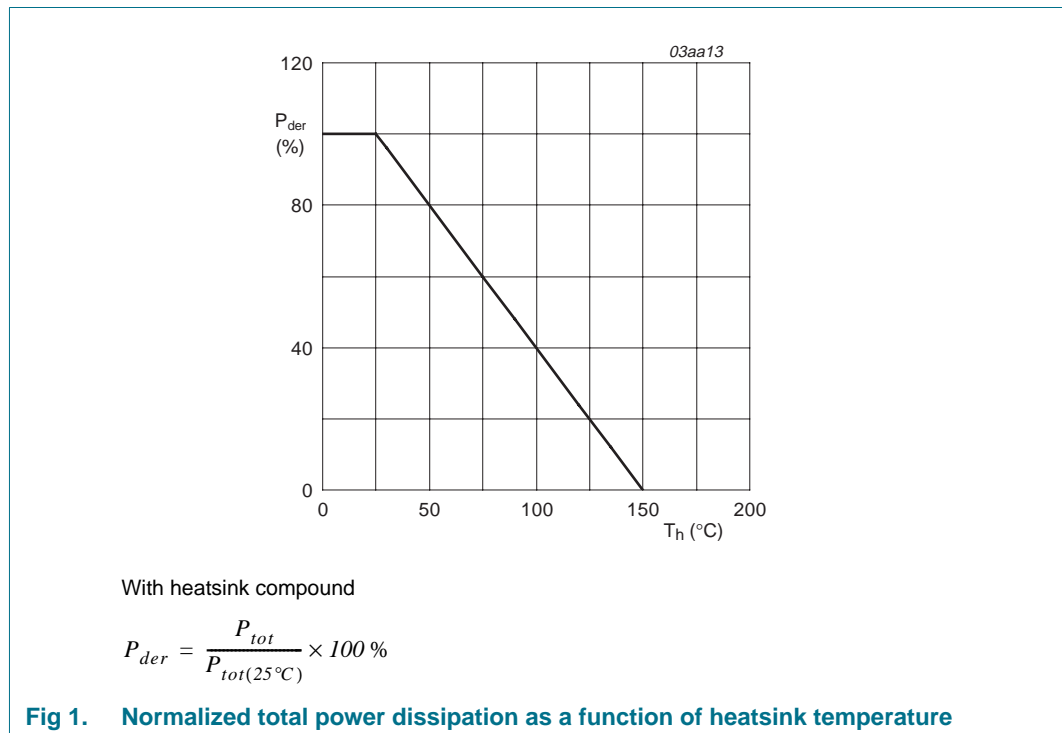
Type number	Package		Version
	Name	Description	
PHE13005X	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 'full pack'	SOT186A

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CESM}	collector-emitter peak voltage	$V_{BE} = 0\text{ V}$	-	700	V
V_{CBO}	collector-base voltage	open emitter	-	700	V
V_{CEO}	collector-emitter voltage	open base	-	400	V
I_C	collector current	DC	-	4	A
I_{CM}	peak collector current		-	8	A
I_B	base current	DC	-	2	A
I_{BM}	peak base current		-	4	A
P_{tot}	total power dissipation	$T_h \leq 25\text{ °C}$; see Figure 1	-	26	W
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	150	°C



5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-h)}$	thermal resistance from junction to heatsink	with heatsink compound; see Figure 2	-	-	4.8	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	-	55	-	K/W

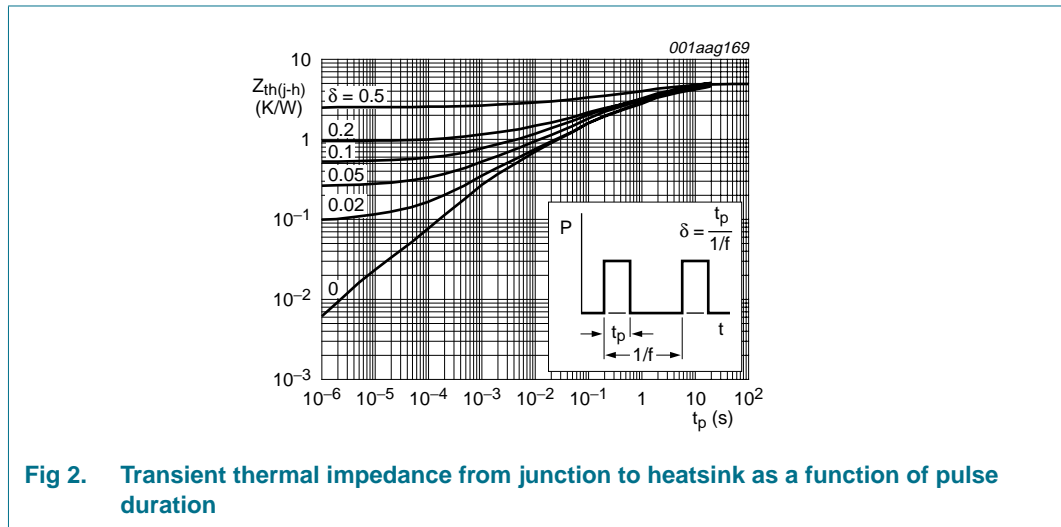


Fig 2. Transient thermal impedance from junction to heatsink as a function of pulse duration

6. Isolation characteristics

Table 5. Isolation limiting values and characteristics

$T_h = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{isol(RMS)}$	RMS isolation voltage	from all three terminals to external heatsink; $f = 50\text{ Hz to }60\text{ Hz}$; sinusoidal waveform; relative humidity $\leq 65\%$; clean and dust free	-	-	2500	V
C_{isol}	isolation capacitance	from pin 2 to external heatsink; $f = 1\text{ MHz}$	-	10	-	pF

7. Characteristics

Table 6. Characteristics

$T_{mb} = 25\text{ °C}$; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
I_{CES}	collector-emitter cut-off current	$V_{BE} = 0\text{ V}$; $V_{CE} = V_{CESM}$	[1]	-	1	mA
		$V_{BE} = 0\text{ V}$; $V_{CE} = V_{CESM}$; $T_j = 100\text{ °C}$	[1]	-	5	mA
I_{CBO}	collector-base cut-off current	$V_{BE} = 0\text{ V}$; $V_{CE} = V_{CESM}$	[1]	-	1	mA
I_{CEO}	collector-emitter cut-off current	$V_{CEO} = V_{CEO(max)} = 400\text{ V}$	[1]	-	0.1	mA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 9\text{ V}$; $I_C = 0\text{ A}$	-	-	1	mA
$V_{CEO(sus)}$	collector-emitter sustaining voltage	$I_B = 0\text{ A}$; $I_C = 10\text{ mA}$; $L_C = 25\text{ mH}$; see Figure 3 and 4	400	-	-	V
$V_{CE(sat)}$	collector-emitter saturation voltage	$I_C = 1\text{ A}$; $I_B = 0.2\text{ A}$; see Figure 10	-	0.1	0.5	V
		$I_C = 2\text{ A}$; $I_B = 0.5\text{ A}$; see Figure 10 and 12	-	0.2	0.6	V
		$I_C = 4\text{ A}$; $I_B = 1\text{ A}$; see Figure 10 and 12	-	0.3	1	V
$V_{BE(sat)}$	base-emitter saturation voltage	$I_C = 1\text{ A}$; $I_B = 0.2\text{ A}$	-	0.85	1.2	V
		$I_C = 2\text{ A}$; $I_B = 0.5\text{ A}$; see Figure 11	-	0.92	1.6	V
h_{FE}	DC current gain	$I_C = 1\text{ A}$; $V_{CE} = 5\text{ V}$; see Figure 9	10	20	60	
		$I_C = 2\text{ A}$; $V_{CE} = 5\text{ V}$; see Figure 9	8	17	40	
Dynamic characteristics						
t_s	storage time	Resistive load; $I_{Con} = 2\text{ A}$; $I_{Bon} = -I_{Boff} = 0.4\text{ A}$; $R_L = 75\text{ }\Omega$; $V_{CC} = 250\text{ V}$; see Figure 5 and 6	-	2.7	4	μs
		Inductive load; $I_{Con} = 2\text{ A}$; $L_B = 1\text{ }\mu\text{H}$; $V_{BE} = -5\text{ V}$; see Figure 7 and 8				
		$I_{Bon} = 0.4\text{ A}$	-	1.2	2	μs
		$I_{Bon} = 0.4\text{ A}$; $T_j = 100\text{ °C}$	-	1.4	4	μs
t_f	fall time	Resistive load; $I_{Con} = 2\text{ A}$; $I_{Bon} = -I_{Boff} = 0.4\text{ A}$; $R_L = 75\text{ }\Omega$; $V_{CC} = 250\text{ V}$; see Figure 5 and 6	-	0.3	0.9	μs
		Inductive load; $I_{Con} = 2\text{ A}$; $L_B = 1\text{ }\mu\text{H}$; $V_{BE} = -5\text{ V}$; $I_{Bon} = 0.4\text{ A}$; see Figure 7 and 8				
		$I_{Bon} = 0.4\text{ A}$	-	0.1	0.5	μs
		$I_{Bon} = 0.4\text{ A}$; $T_j = 100\text{ °C}$	-	0.16	0.9	μs

[1] Measured with half sine-wave voltage (curve tracer).

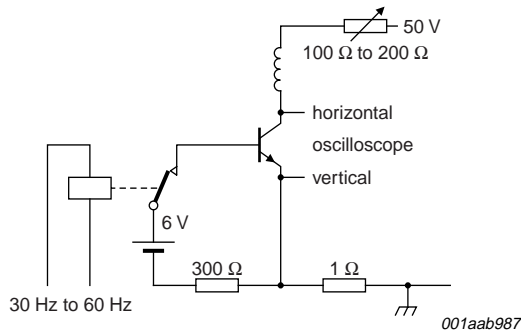


Fig 3. Test circuit for collector-emitter sustaining voltage

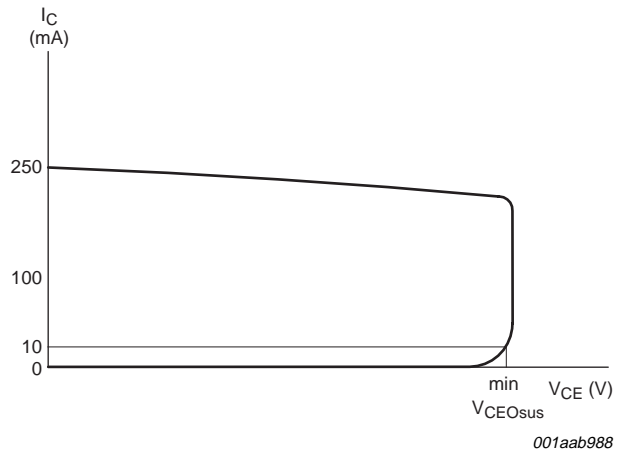
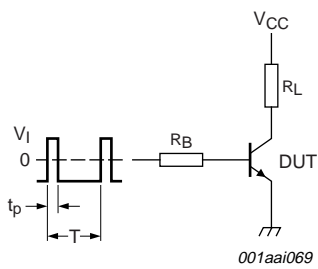


Fig 4. Oscilloscope display for collector-emitter sustaining voltage test waveform



$V_I = -6 \text{ V to } +8 \text{ V}$; $V_{CC} = 250 \text{ V}$; $t_p = 20 \mu\text{s}$;
 $\delta = t_p / T = 0.01$.
 R_B and R_L calculated from I_{Con} and I_{Bon} requirements.

Fig 5. Test circuit for resistive load switching

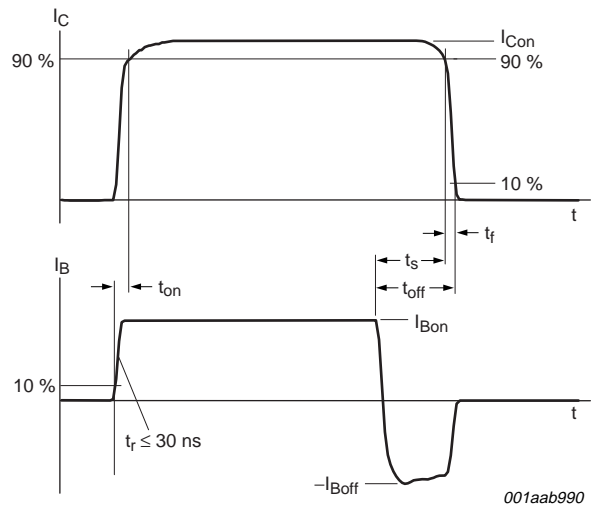
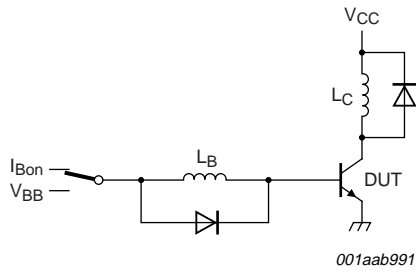


Fig 6. Switching times definitions for resistive load



$V_{CC} = 300\text{ V}; V_{BB} = -5\text{ V}; L_C = 200\ \mu\text{H}; L_B = 1\ \mu\text{H}$

Fig 7. Test circuit for inductive load switching

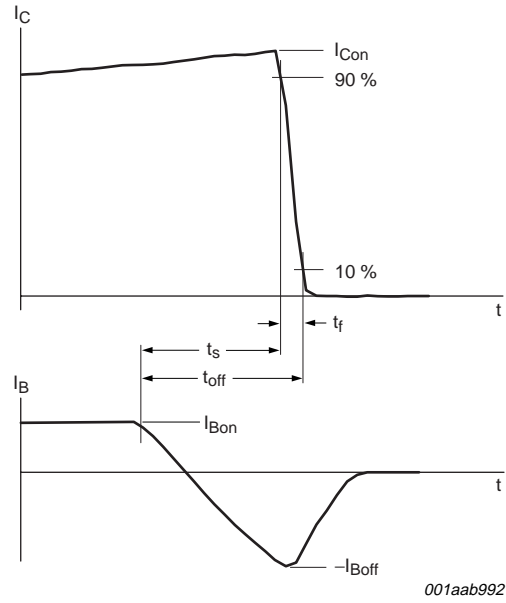
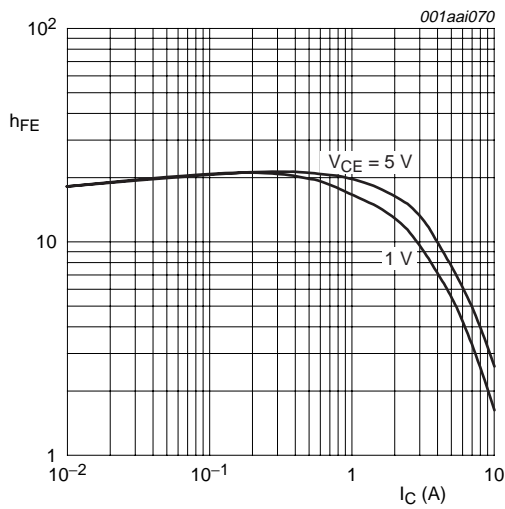
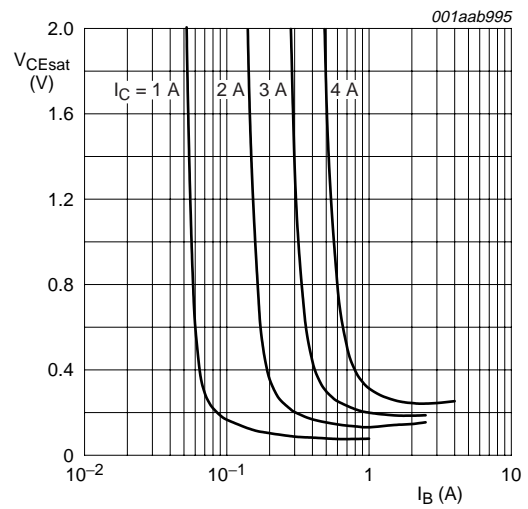


Fig 8. Switching times definitions for inductive load



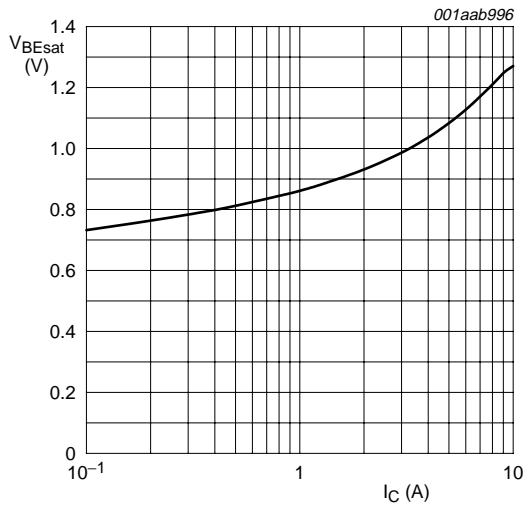
$T_j = 25\text{ }^\circ\text{C}$

Fig 9. DC current gain as a function of collector current; typical values



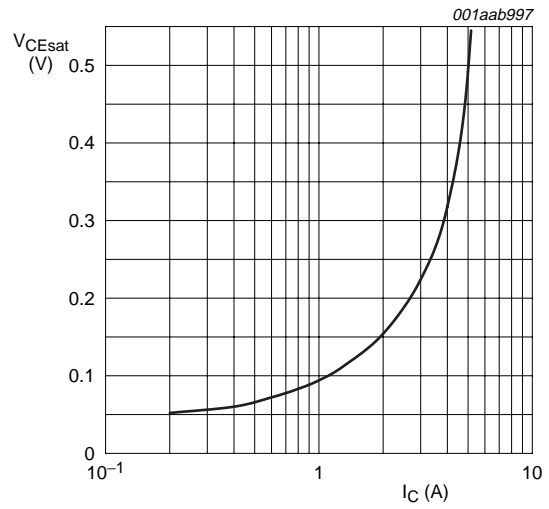
$T_j = 25\text{ }^\circ\text{C}$

Fig 10. Collector-emitter saturation voltage; typical values



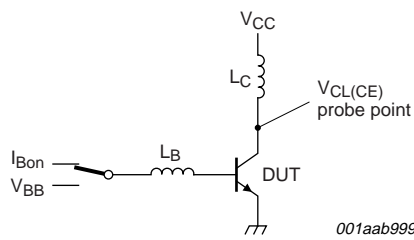
$I_C/I_B = 4$

Fig 11. Base-emitter saturation voltage; typical values



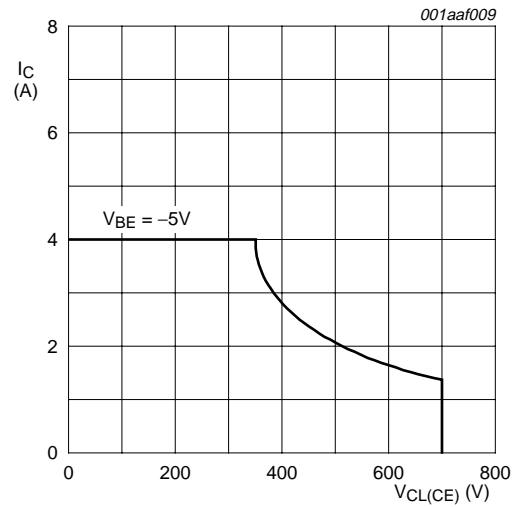
$I_C/I_B = 4$

Fig 12. Collector-emitter saturation voltage as a function of collector current; typical values



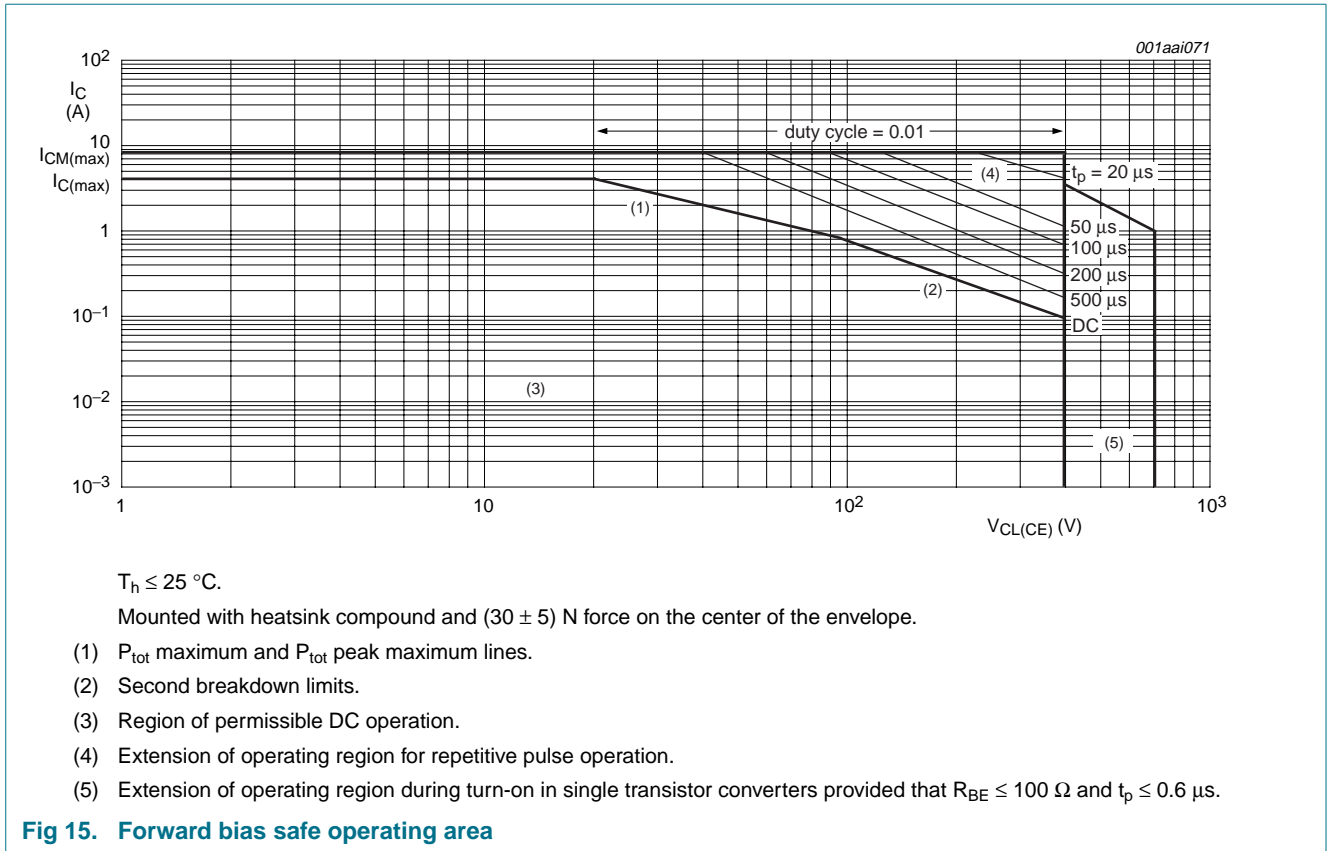
$V_{CL(CE)} \leq 1000$ V; $V_{CC} = 150$ V; $V_{BB} = -5$ V;
 $L_B = 1$ μ H; $L_C = 200$ μ H

Fig 13. Test circuit for reverse bias safe operating area



$T_j \leq T_{j(max)}$

Fig 14. Reverse bias safe operating area



8. Package information

Epoxy meets requirements of UL94 V-0 at 3.175 mm.

9. Package outline

Plastic single-ended package; isolated heatsink mounted;
1 mounting hole; 3-lead TO-220 'full pack'

SOT186A

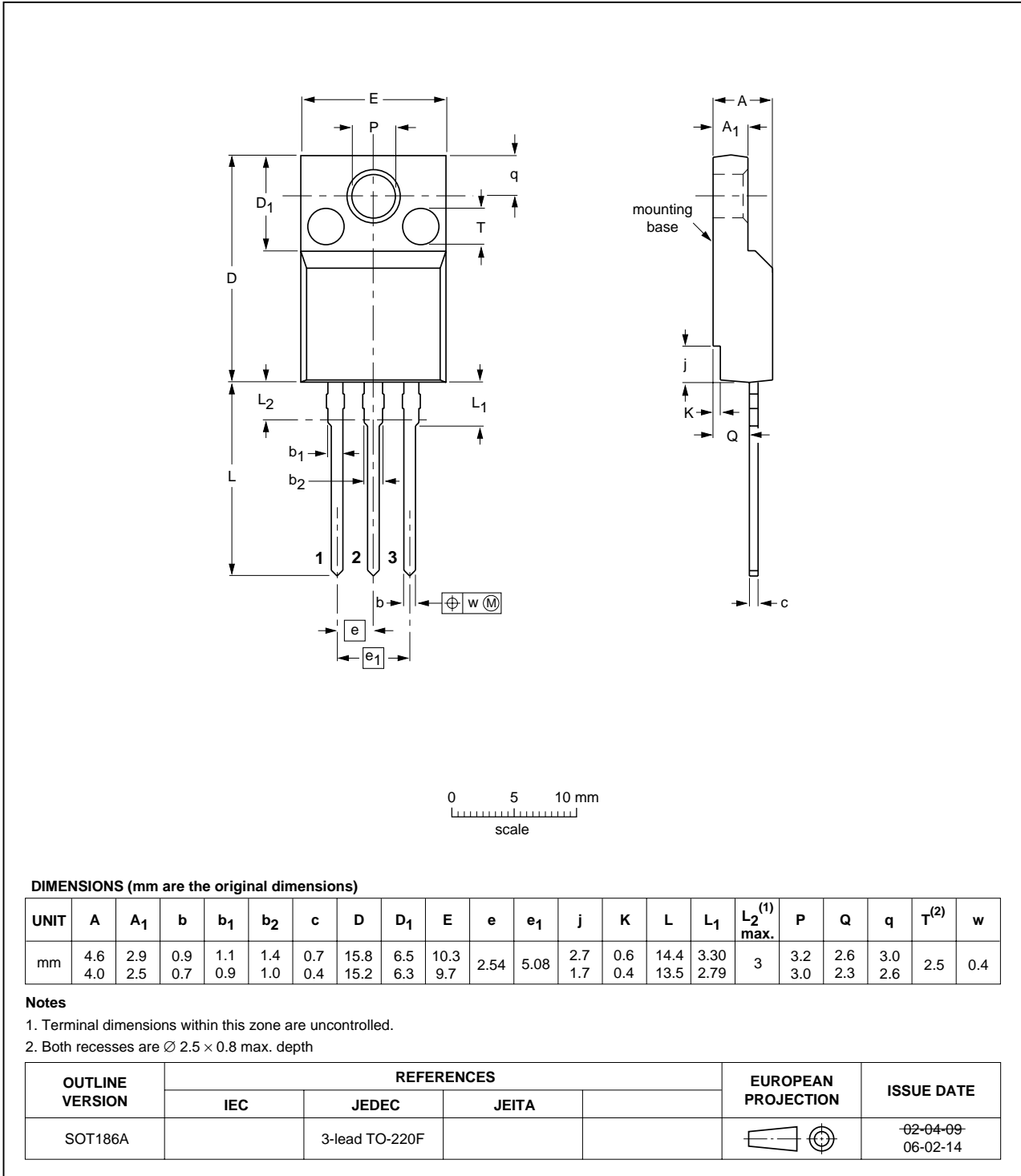


Fig 16. Package outline SOT186A (3-lead TO-220F)

10. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHE13005X_1	20080515	Product data sheet	-	-

11. Legal information

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Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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